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Application/Control No.	Applicant(s)/Patent under Reexamination
10/712,006	SHARKEY ET AL.
Examiner	Art Unit

3766

Yun H. Lee

SEARCHED				
Class	Subclass	Date	Examiner	
607	105,154, 117	8/31/2007	YHL	
				
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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PG Pu	b Search	8/31/2007	YHL
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	· EXMR	
EAST Search	8/31/2007	YHL	
Inventor Name Search	8/31/2007	YHL	
Allowability discussed with Ken Schaetzle	8/13/2007	YHL	